

TOSHIBA CMOS Linear Integrated Circuit Silicon Monolithic

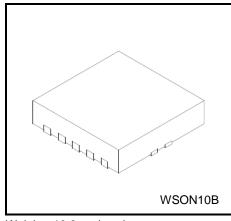
TCKE805 Series

18 V, 5A eFuse IC with Adjustable Over Current Protection and Reverse Blocking FET Control

The TCKE805 series are 18 V high input voltage Single Inputs—Single Output eFuse IC. It can be used as a reusable fuse, and includes protection features like adjustable over current limit by an external resistor, short circuit protection, over voltage clamp, adjustable slew rete control by an external capacitance, under voltage protection, thermal shutdown and reverse current blocking by external MOSFET control circuit.

Switch ON resistance is only 28 m Ω , high output current is up to 5.0A, and wide input voltage operation characteristics makes this product ideal for power management applications such as in the power supply circuit of hard disk drive and battery charging applications.

This device is available in 0.4mm pitch small package WSON10B (3.0 mm x 3.0 mm, t: 0.7 mm (typ)). Thus this devices is ideal for various applications such as portable electronics that require high-density boards.



Weight: 19.3mg (typ.)

Feature

- High input voltage: V_{IN max} = 18.0 V
- High output current: I_{OUT} (DC) = 5.0 A
- Low ON resistance : $R_{ON} = 28 \text{ m}\Omega$ (typ.)
- Adjustable overcurrent limit : up to 5.0 A
- · Fixed over voltage clamp
 - 5V power rail: 6.04 V (typ.)
- · Programmable slew rate control by external capacitance for Inrush current reduction
- Programmable under voltage lockout by external resistor
- · Reverse current blocking support by built in MOSFET Driver
- · Adjustable under voltage lockout(UVLO) by external resistor
- Thermal shutdown
- Auto-discharge
- · Small package:

WSON10B (3.0 mm x 3.0 mm, t: 0.7 mm (typ))

Notice

This device is sensitive to electrostatic discharge.

Please ensure equipment and tools are adequately earthed when handling.

Start of commercial production 2019-11



Absolute Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Input voltage	VIN	-0.3 to 18.0	V
ILIM voltage	VILIM	-0.3 to 6.0	V
dV/dT voltage	V _d V/ _d T	-0.3 to 6.0	V
Control voltage	VEN/UVLO	-0.3 to 18.0	V
Output voltage	Vout	-0.3 to V _{IN} + 0.3 or 18.0 V which is smaller	V
External MOSFET voltage	VEFET	-0.3 to 30.0	V
Power dissipation	PD	2.4 (Note 1)	W
Junction temperature	Tj	150	°C
Storage temperature	T _{stg}	-55 to 150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note1: Rating at mounting on a board: FR4 board. (76.2mm * 114.3mm * 1.6mm, 4 layer)

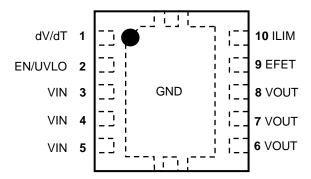
Operating Ranges

beruting ranges					
Characteristics	Symbol	Ran	Unit		
Input voltage	VIN	4.4 to	V		
Output current	lout	Continuous output current 0 to 5.0		А	
I _{LIM} External resistance	RILIM	20 to 300		kΩ	
Control voltage	VEN/UVLO	0 to 18		V	
External MOSFET voltage	VEFET	0 to V _{IN} + 4.9		V	
Operating Ambient temperature range	Ta_opr	-40 to 85		°C	
External capacitance	C _{dV/dT}	1 (typ), 100 (max)		nF	



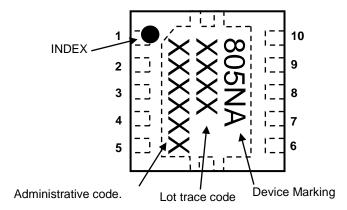
Pin Assignment (Top view)

WSON10B



Top Marking (Top view)

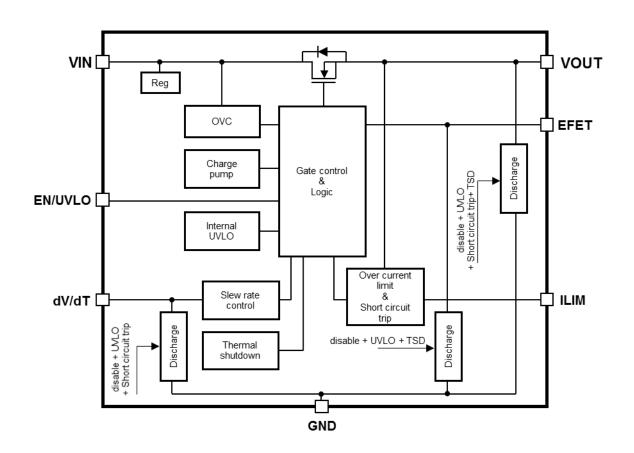
Example: TCKE805NA





Product list					
Part number	Over voltage	CE	Fault	Тор	Package
	Clamp	function	Response	Marking	
TCKE805NA	6.04V (typ)	Active High	Auto-retry	805NA	WSON10B (3.0 mm x 3.0 mm, t: 0.7 mm (typ))
TCKE805NL	6.04V (typ)	Active High	Latched	805NL	WSON10B (3.0 mm x 3.0 mm, t: 0.7 mm (typ))

Block Diagram





PIN Description

PIN Name	Description
EN/UVLO	This pin has two functions. One function turns on the output voltage of the internal
	MOSFET and EFET terminal as an enable signal. Another function can be used as a
	UVLO trip point with external resistors.
ILIM	Current limit set input. A resistor between ILIM terminal and GND set the current limit.
dV/dT	Rise time set input. A capacitor between dV/dT terminal and GND set the slew rate of
av/a1	VOUT when the device turns on.
EFET	Connect this pin to the gate of a blocking Nch MOSFET. This pin can be left floating if it
EFEI	is not used
VIN	Supply Input. Input to the power switch and the supply voltage for the device.
GND	Ground.
VOUT	Output. Output of the power switch.

Operation Logic Table

	EN/UVLO "Low"	EN/UVLO " High"
Output	OFF	ON



TCKE805 series DC Characteristics (Unless otherwise specified, Ta = -40 to 85°C, VIN = 5V, RILIM = $20k\Omega$)

Charactariation	Cumbal	Tool Oos dilion	Ta = 25°C			Ta = -40 to 85°C		1.1-21
Characteristics	Symbol	Test Condition	Min.	Тур.	Max.	Min.	Max.	Uni
Basic operation								
VIN under voltage lockout (UVLO) threshold, rising	VIN_UVLO		_	4.15	_	4.00	4.40	V
VIN under voltage lockout (UVLO) hysteresis	VIN_UVhyst		_	5	_	_	_	%
EN/UVLO threshold voltage, rising	V _{ENR}	_		1.1		1.0	1.2	V
EN/UVLO threshold voltage, falling	V _{ENF}	_		0.96	_	0.89	1.01	V
On resistance	Ron	I _{OUT} = 1.5 A	_	28	_	_	38	mΩ
Quiescent current (ON state)	IQ	$V_{EN} = 3 \text{ V}, \text{ R}_{ILIM} = 120 \text{ k}\Omega,$ $I_{OUT} = 0 \text{ A}$	_	0.46	_	_	0.61	m/
Quiescent current (OFF state)	IQ(OFF)	EN = 0V	_	33	_	_	48	μΑ
dV/dT control								
Capacitor Voltage	V _d V/ _d T	_	_	3	_	_	_	V
Charging Current	l _{dV/dT}	V _{dV/dT} =0V	_	250	_	_	_	nA
Discharge resistance	R _{dV/dT}	VEN = 0 V, IdV/dT =10 mA	_	5	_	3	9	Ω
dV/dT to OUT gain	GAIN _{dV/dT}	(Note2) V _{dV/dT} = 0.3 V	_	10.5	_	_	_	_
External FET Gate driver						•		
Charging Current	I _{EFET}	VEFET = 5 V (Note2)	_	2	_	_	_	μА
Output voltage	VEFET	(Note2)	_	VIN+4.9	_	VIN+4.4	VIN+5.3	V
Discharge resistance	REFET	V _{EN} = 0 V, I _{EFET} = 20 mA	_	24	_	12	40	Ω
Over-voltage Protection						•		•
Over voltage clamp (OVC)	Vovc	V _{IN} = 7 V, I _{OUT} = 1 A	_	6.04	_	5.62	6.45	٧
Over-current Protection								
		$R_{ILIM} = 20 \text{ k}\Omega, V_{IN} - V_{OUT} = 1 \text{ V}$	_	5.15	_	4.44	5.87	
	ILIM (IOUT_CL)	RILIM = 24 k Ω , VIN - VOUT = 1 V	_	4.38	_	3.88	4.88	- A
		$R_{ILIM} = 35.1 \text{ k}\Omega, V_{IN} - V_{OUT} = 1 \text{ V}$	_	3.06	_	2.70	3.41	
		$R_{ILIM} = 62 k\Omega$, $V_{IN} - V_{OUT} = 1 V$	_	1.78	_	1.52	2.04	
Over current limit (Note3)		RILIM = 120 k Ω , VIN - VOUT = 1 V		0.96	_	0.76	1.16	
		$R_{ILIM} = 250 \text{ k}\Omega, V_{IN} - V_{OUT} = 1 \text{ V}$		0.50	_	0.35	0.65	
		R _{ILIM} = 0 Ω, V _{IN} - V _{OUT} = 1 V	_	0.64	_	_	_	
		RILIM = OPEN, VIN - VOUT = 1 V		0.64	_	_		
Short-circuit current limit	I _{SCL}	(Note2),(Note4)	_	0.15	_	0.05	0.50	Α
Fast trip comparator level	IFASTTRIP (ISHORT_TRIP)	_	_	I _{LIM} × 1.6	_	_	_	Α
ILIM short resistor detect Threshold	RSHORTLIM	_	_	11	_	_	_	kΩ
Thermal Protection		•		•				
Thermal shut down Threshold	T _{SD}	Тј	_	160	_	_	_	°C
Thermal shut down Hysteresis	T _{SDH}	Tj		20	_	_	_	°C

Note2: This parameter is warranted by design.

Note3: Pulsed testing techniques used during this test maintain junction temperature approximately equal to ambient temperature.

Note4: Hard short less than 10 m Ω .



TCKE805 AC Characteristics (Unless otherwise specified, Ta = -40 to 85°C, VIN = 5V, RILIM = 20k Ω , RLOAD=5 Ω , CIN = COUT = 1 μ F)

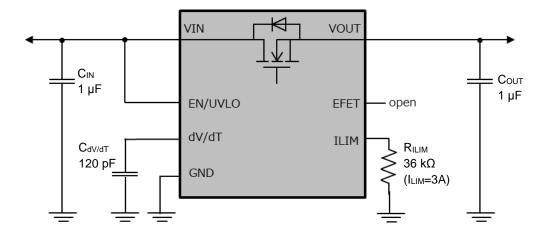
Characteristics	Symbol	Test Condition		Тур.	Max.	Unit
V _{OUT} on time	ton	VEN↑ to I _{IN} = 100 mA, 1 A resistive load at V _{OUT} , C _{dV/dT} = OPEN (Note5)		330	_	μS
Vout off time	tOFF	VEN↓ to VEFET↓, CEFET = OPEN (Note5)	_	0.96	_	μS
Output ramp time	tdV/dT	V _{EN} ↑ to V _{OUT} become V _{IN} * 90%, C _{dV/dT} = OPEN (Note6)		400	700	μS
		V _{EN↑} to V _{OUT} become V _{IN} * 90%, C _{dV/dT} = 1 nF (Note5)	_	2.3	_	ms
Fast trip comparator delay	tFastOffDly	IOUT > IFASTTRIP to IOUT = 0 (Switch off) (Note5)		150	_	ns
EFET on time	tefet-on	VEN↑ to VEFET = VIN, CEFET = 1 nF(Note5)		2.6		ms
		V _{EN↑} to V _{EFET} = V _{IN} , C _{EFET} = 10 nF(Note5)	_	25	_	ms
FFFT ""	tefet-off	V _{EN} ↓ to V _{EFET} = 1 V, C _{EFET} = 1 nF(Note5)		1.2		μS
EFET off time		V _{EN} ↓ to V _{EFET} = 1 V, C _{EFET} = 10 nF(Note5)	_	2.9	_	μS

Note5: This parameter is reference only. Note6: This parameter is warranted by design.



Application Note

1. Application circuit example



1) Peripheral circuits

Connect the power supply to the input terminal V_{IN} . During normal operation, almost the same voltage as the V_{IN} voltage is output from the output terminal V_{OUT} through the internal MOSFET.

If the current suddenly decreases, for example, when short-circuiting or overcurrent is protected, high-spike voltages may be generated due to back electromotive force of inductance components such as wirings connected to the input/output terminals of the eFuse IC, causing damage to the eFuse IC and resulting damage. In this case, a positive spike voltage is generated on the input side and a negative spike voltage is generated on the output side.

When designing boards, design patterns so that the length of the wires on the input-side and output-side of the eFuse IC is as short as possible. Also, the GND wiring area should be as wide as possible to reduce the impedance. C_{IN} functions to suppress the peak value against the positive spike voltage generated by the inputs. The peak value V_{SPIKE} of the spike voltage and the capacitance value of the C_{IN} have the following relationships. It can be understood that the spike voltage can be reduced by increasing the C_{IN} .

$$V_{SPIKE}(V) = V_{IN} + I_{OUT} \times \sqrt{\frac{L_{IN}}{C_{IN}}}$$

L IN: effective inductance component of the input terminal (H), I OUT: output current (A)

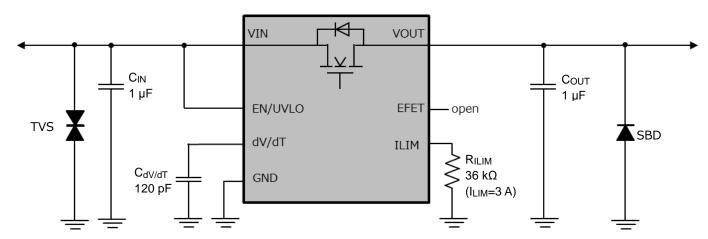
V SPIKE: peak value of spiked voltage generated (V), V IN: power supply voltage during normal operation (V)

Toshiba eFuse IC recommends 1 μ F for C_{IN} and C_{OUT} , and in most cases this volume is effective enough. Be sure to measure it on the actual PCB board. In order to prevent damage due to spike voltage, it is also recommended to connect a TVS diode (ESD protection diode) to the input terminal and a SBD (Schottky barrier diode) to the output terminal.

TVS diodes are also effective in preventing surge damage caused by external noises input from power supplies and GND wires. In addition to protecting the eFuse IC, TVS diodes are also effective in preventing damage to ICs and devices on the load side. For eFuse IC use, connect between the input terminal and GND. For negative spike voltage generated on the output side, an SBD can be connected to prevent the output potential from dropping more than GND. This protects not only the eFuse IC but also the ICs and devices connected as loads. Connect the SBD with the GND as the anode between the output terminal of the eFuse IC and the GND.

As noted above, TVS diodes and SBDs are recommended for eFuse IC because they can provide more robust protective features. The diagram below shows the peripheral circuit diagram when a TVS diode and an SBD are added.





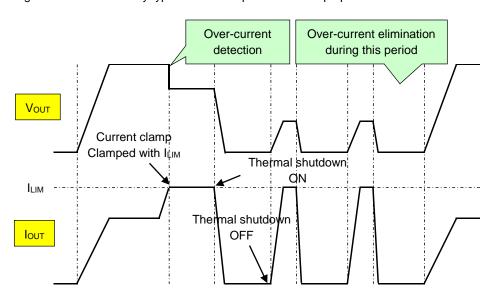
Our eFuse IC recommends DF2S23P2CTC as the TVS diode and CUHS20F30 as the SBD diode.

2) Operation of the thermal shutdown function

The overcurrent protection function prevents damage to the IC and load by suppressing power consumption in the event of an error. If the output current exceeds the limit current (I LIM) due to a load error or short circuit, the output voltage and output current also decrease, thereby limiting the power consumed by the ICs and the load.

In addition to the short-circuit protection function, which will be described later, it is double-protected against overcurrent, which greatly contributes to the prevention of ignition and smoke.

The timing chart of the auto-retry type overcurrent protection clamp operation is shown below.

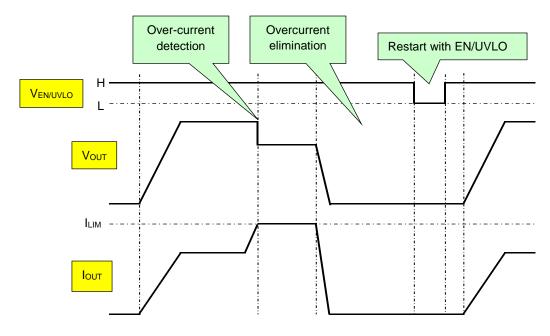


Timing chart of overcurrent protection operation (auto-retry type)

When the output current reaches ILIM and overcurrent is detected, the output current is clamped so that no more current than ILIM flows. At this time, the output voltage drops slightly according to the relationship between the output voltage and the current, which will be described later. If the overcurrent is not resolved at this stage, this condition is maintained and the IC temperature continues to rise. Soon the IC reaches the operating temperature of the thermal shutdown function, the MOSFET is switched off, and the eFuse IC stops operating.



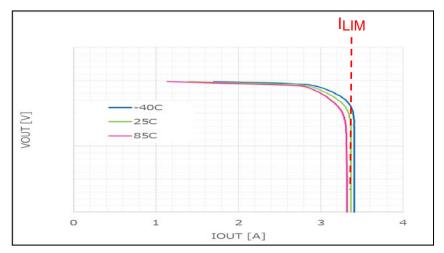
Next, the timing chart of the overcurrent protection clamp operation of the latch type is shown in the figure below. This condition is maintained until the latch type is restarted by the control signals of the EN/UVLO terminal. However, the auto-retry type repeats the restoration attempt by stopping the operation \rightarrow lowering the temperature \rightarrow releasing the thermal shutdown \rightarrow clamping the current \rightarrow protecting the overheat \rightarrow raising the temperature \rightarrow protecting the overheat \rightarrow Stopping the operation until the overcurrent is eliminated.



Timing chart of overcurrent protection operation (latch type)

3) Setting the overcurrent protection function

The following figure shows the relationship between output voltage and current during overcurrent protection clamp operation.



Output Voltage-Current Characteristics during Overcurrent Protection Clamp Operation

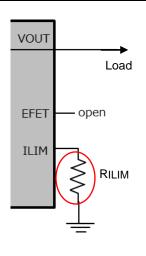
Toshiba eFuse IC has a variable current limit. By selecting the external resistor R_{ILIM} of the I_{LIM} terminal appropriately, the current limit can be set to the optimum value for each application. The I_{LIM} calculations are the same as those for the TCKE8 series, and are as shown below. However, the deviation between the theoretical value and the measured value is large when the current is 1A or higher. Be sure to check the resistance value with the actual machine when selecting the resistance value.

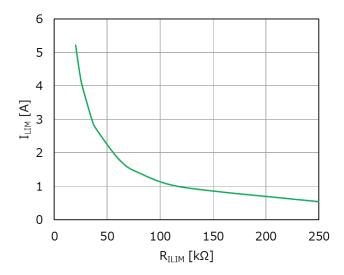
$$I_{LIM}(A) = 0.13 + 101.8/R_{ILIM}(k\Omega)$$

R_{ILIM}: I_{LIM} terminal external resistor (kΩ)

The following is a diagram of the peripheral circuitry of the I_{LIM} terminal and the relation between R_{ILIM} and I_{LIM} .







ILIM Terminal External Circuits

RILIM-ILIM Characteristics

For reference table below shows the resistivity of the RILIM and the current ILIM.

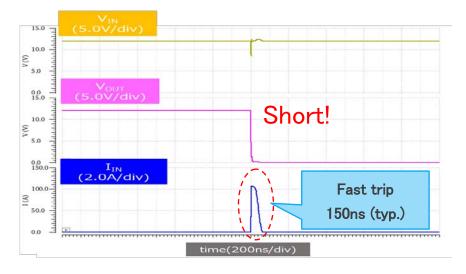
	•	
R _{ILIM} (kΩ)	I _{LIM} (A) (typ.)	Conditions
20	5.15	
24	4.38	
36	3.00	
62	1.78	VIN-VOUT=1 V
120	0.96	VIN-VOUT=I V
250	0.5	
0	0.64	
OPEN	0.64	

4) Short Circuit protection

The short-circuit protection function prevents excessive current from flowing by stopping operation when the power supply line or load is short-circuited due to some kind of abnormality. If the output current is 1.6 times the current limit (I_{LIM}) for a very short period of time, the output is judged to be short-circuited and this function operates.

Toshiba eFuse IC employs an ultra-high-speed short-circuit protecting circuit (Fast trip function). Simulation results are shown to suppress the current to near zero at 150 ns (typ.) from the occurrence of the short-circuit.

The following table shows the operating waveforms of the simulated Fast trip function.



Output voltages and output current waveforms during fast trip operation

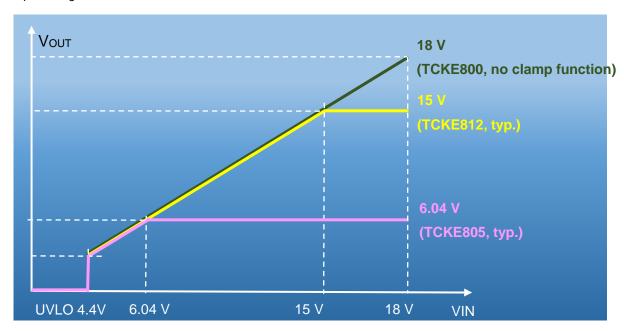
The short-circuit protection circuit performs the return operation 100 µs after Fast trip. If the short-circuit continues, the protection operation starts again. The latch type does not attempt to recover thereafter, but continues to be



protected until it is restarted by the control signal. The auto-retry type attempts to recover until the short-circuit condition is resolved by using the thermal shutdown cycle.

5) Overvoltage protection function

The overvoltage clamp function clamps the output voltage with a limited voltage and prevents overvoltage from being applied to the load without outputting any more voltage. This function is available on the TCKE805/812 series and is not included in the TCKE800 series. The limit voltages are set to 6.04 V (standard) for the TCKE805 series and 15 V (standard) for the TCKE812 series. The diagram below shows the relation between the input voltage and the output voltage of TCKE800/805/812 series.



Overvoltage Characteristics of TCKE800/805/812

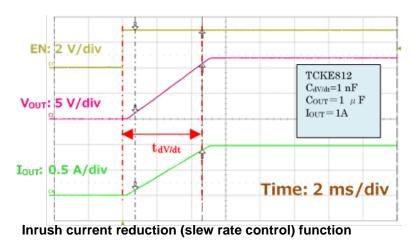
Similar to the overcurrent protection and short-circuit protection, the auto-retry type will attempt to recover from the overvoltage, but the latch type will retain this state until it is restarted.

6) Inrush current reduction

When the output is turned on, an inrush current flows to charge the capacitor connected to the load side. If this current is too large, the overcurrent protection circuit may malfunction, making it impossible to start up, or the output voltage may overshoot.

To prevent this, this function controls the slew rate when the output voltage rises by limiting the inrush current.

The following figure shows the rise of the output voltage (V OUT) and the inrush current when the inrush current is limited by this function. As shown below, the output current at the start-up is gradually increasing.



7) Setting of slew rate control for inrush current reduction

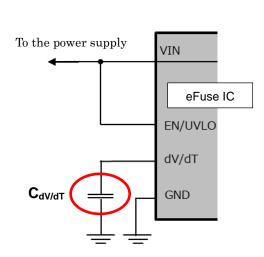


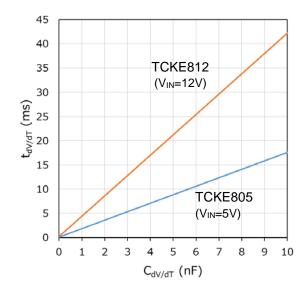
To shiba eFuse IC has a variable inrush current function. The external capacitor at the dV/dT terminal can be used to appropriately set the rise time ($t_{dV/dT}$) of the output voltage. The formula for the rise time is as follows:

$$tdv/dt$$
 (s) = $0.36 \times 10^{6} \times VIN \times (CdVdT+50 \times 10^{-12}) + 3.0 \times 10^{-4}$

V_{IN}: input voltage (V), C_{dV/dT}: external capacitance of dV/dT terminal (F)

The following chart shows the peripheral circuit diagram of the dV/dT terminal and graphs showing the relation between CdV/dT and tdV/dT.



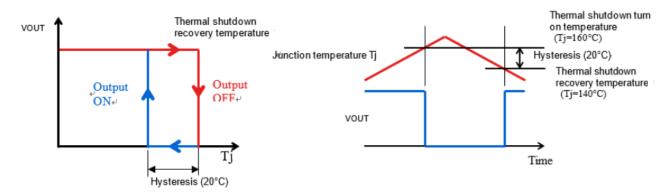


C_{dV/dT}-t_{dV/dT} Characteristics of External Circuits around dV and dT Terminals

8) Thermal shutdown function

Thermal shutdown (overheat protection) is a function to shut off and protect the output by setting the IC to standby when a large current continues to flow to the output and the junction temperature of the eFuse IC exceeds the set temperature.

The following figure shows the operation image of the thermal shutdown function. When the thermal shutdown is activated, no current flows through the IC, and the junction temperature begins to drop. Hysteresis is given to the operating temperature and the recovery temperature of the thermal shutdown. The IC will not recover until the temperature drops after a certain period of time.



Operation of thermal shutdown function



9) Reverse current blocking

As an option, Toshiba eFuse IC can prevent reverse current flow by attaching an N-channel MOSFET to the EFET terminal. The reverse current blocking function prevents reverse current from the output side to the input side when the operation of the eFuse IC is stopped, for example, by turning off the power supply of the VIN or controlling the input side by the EN/UVLO terminal.

The circuit for using the reverse current blocking function is shown in the figure below.

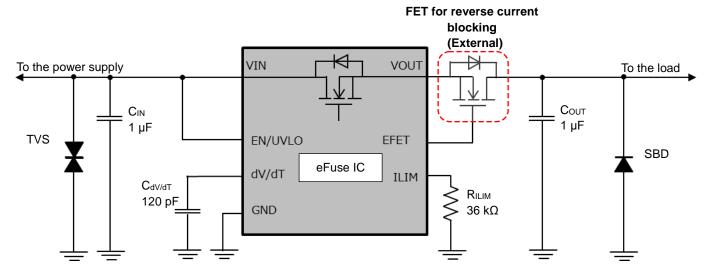


Fig. 3.12 Examples of eFuse IC Peripheral Circuits with Reverse current blocking Function

Our SSM6K513NU is recommended as an external FET to prevent backflow. SSM6K513NU main characteristics are as follows:

- Drain-source voltage: V_{DSS} = 30 V
- Gate-Source Voltage: V_{GSS} = 20 V
- Drain current: I_D = 15 A
- Drain-source on-resistance: R_{DS (ON)} =8 mΩ @VGS=4.5 V

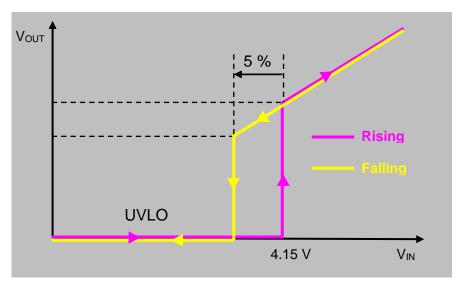
When using other products, select a product with as low of on-resistance as possible, with sufficient V_{DSS} and I_{D} margins for the power supply voltage and the load current that is expected to be used.

The EFET terminal outputs the internally boosted voltage VIN+4.9V (typ.). If this function is not used, open the terminal.

10) Under voltage lockout function (UVLO)

This function stops the operation of the eFuse IC when the input voltage is low and prevents malfunction of the load. The TCKE8 series will not operate unless the input voltage exceeds 4.15 V (typ.). This voltage has hysteresis at the rising and falling edges. At the falling edge, the voltage stops at 5% (typ.) lower than 4.15 V at the rising edge (about 3.95 V).

The following figure shows the operation of this function.



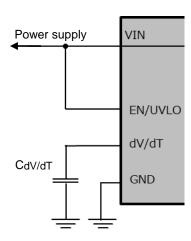


11) EN/UVLO terminal function

The TCKE8 series is equipped with EN/UVLO terminal, and this terminal can be used to control the operation of the whole eFuse IC. It is also possible to set the operating voltage of the under voltage lockout function to the optimum value by externally attaching a resistor.

The following are examples of uses for this terminal.

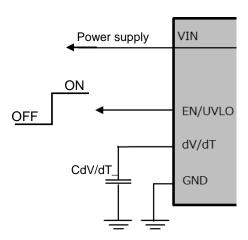
(1) When the operation voltage of the under voltage lockout function is not changed or the operation control is not performed.



Connections of EN/UVLO terminals (Direct V_{IN} connection)

Connect the EN/UVLO terminal directly to the V_{IN} terminal. This eliminates the need for pull-up resistors in the TCKE8 series. The EN/UVLO terminal is designed to be breakdown-voltage 18 V, and the V_{IN} terminal and the EN/UVLO terminal can be directly connected. This helps reduce the number of parts.

(2) When the operation voltage of the under voltage lockout function is not changed and the operation control is performed from the outside.



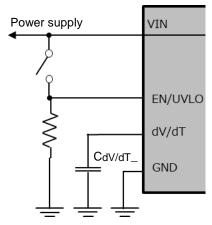
Connecting Examples of EN/UVLO Terminals (External Control)

Connect external control signals directly into the EN/UVLO terminal. Since the on/off threshold voltages of the EN/UVLO terminals are hysteretic, set the "H" level of the control signal to be 1.1 V (typ.) or higher and the "L" level of the control signal to be 0.96 V (typ.)or lower.

If the EN/UVLO terminal is open (indefinite), the eFuse IC operation may become abnormal. Be careful not to open this terminal even when it is at the "L" level.



(3) When the operation voltage of the under voltage lockout function is not changed and the operation is controlled by the short-circuit switch with the V_{IN} terminal.

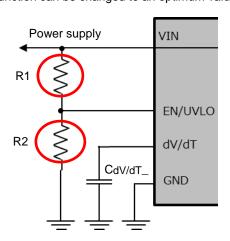


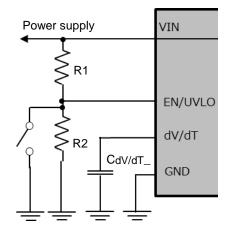
Connection examples of EN/UVLO terminals (connected by V_{IN} and switches)

Switches can be directly connected to the V_{IN} so that the operation can be controlled. A pull-down resistor is required to prevent the EN/UVLO terminal from being opened when the SW1 is opened. The value of the pull-down resistor may be any value that does not cause the EN/UVLO terminal to become indefinite. However, when the SW1 is conducting, consider the current flowing through R1, and check the value with the actual device to determine the value of the pull-down resistor.

(4) To change the operating voltage of the under voltage lockout function

By adding an external resistor to the EN/UVLO terminal, the operating voltage of the under voltage lockout function can be changed to an optimum value. An example of the circuit is shown in the figure below.





a) In case of no operation control

b) in case of operation control

Connections of EN/UVLO terminals (V_{IN} resistive division)

a) is an example of the circuit when the operation control is not performed by the EN/UVLO terminal, and **b)** is an example of the circuit when the operation control is performed.

As shown in the drawing, operation is stopped when the input voltage drops by controlling the operation of the EN/UVLO terminal with the voltage obtained by dividing the input voltage by an external resistor. The operating voltage of the under voltage lockout function can be set to the optimum value by properly selecting the external resistance. However, the voltage cannot be set to 4.15 V or less.

The equation for setting $V_{IN}_UVLO_{(fall)}$ by controlling the external resistors R1 and R2 of the EN/UVLO terminal is as follows.

$$V_{IN}-UVLO_{(fall)}(V) = \frac{R2}{R1 + R2} \times V_{ENF}(V)$$

V ENF: EN threshold (falling) 0.96 V (typ.)

As described above, the control voltage of the EN/UVLO terminal is hysteretic, and therefore the voltage to be



activated at the time of rising changes. The start-up voltage V_{IN}_UVLO_(rise) is calculated by the following equation.

$$V_{IN_}UVLO_{(fall)}(V) = \frac{R2}{R1 + R2} \times V_{ENF}(V)$$

V ENR: EN Threshold Voltage (rising) 1.1 V (typ.)

As shown in **b)** above, the switch can be connected in parallel with R2 to control the operation. In this case, contrary to the case of (3), the eFuse IC stops operating at the time of SW1 conduction. At this time, R1 is the current limiting resistor. Be careful when selecting the resistors for R1 and R2.

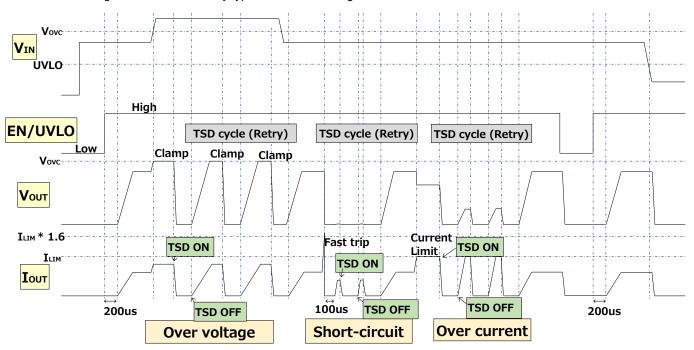
12) Precautions regarding protection functions

Toshiba eFuse IC has various protection functions. Be aware that not every function will cause the eFuse IC to cease functioning. When using these products, please read through and understand the concepts described and follow absolute maximum ratings from the information above or from our 'Semiconductor Reliability Handbook'. Please operate these products below absolute maximum ratings in all instances. Furthermore, Toshiba highly recommends inserting failsafe systems into the design.



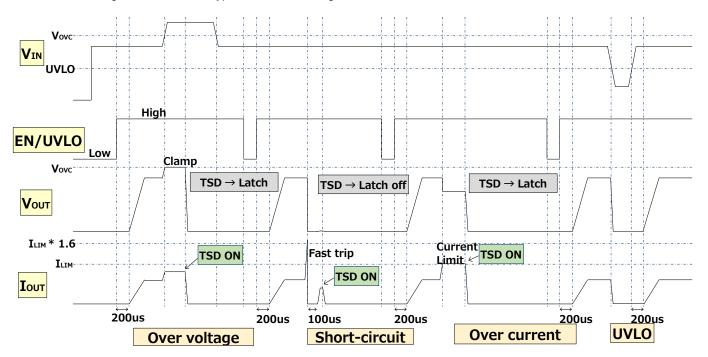
13) Timing chart

The timing chart of the auto-retry type is shown in the figure below.



Timing chart (auto-retry type)

The timing chart of the latch type is shown in the figure below.



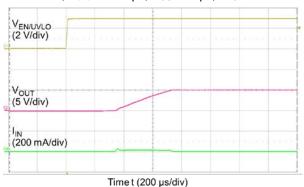
Timing chart (latch type)



Representative Typical Characteristics

ton Response





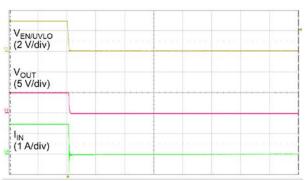
 V_{IN} = 5 V, C_{dVdT} = 120 pF, C_{OUT} = 1 μ F, R_{LOAD} = 3.3 $k\Omega$



Time t (200 µs/div)

toff Response

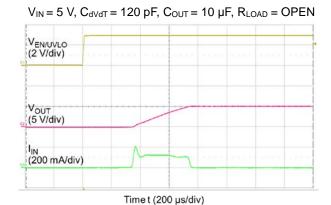
$$V_{IN}$$
 = 5 V, C_{dVdT} = 120 pF, C_{OUT} = 1 μ F, R_{LOAD} = 3.3 $k\Omega$

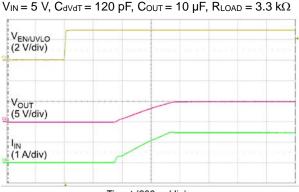


Time t (200 µs/div)

Over voltage clamp

The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



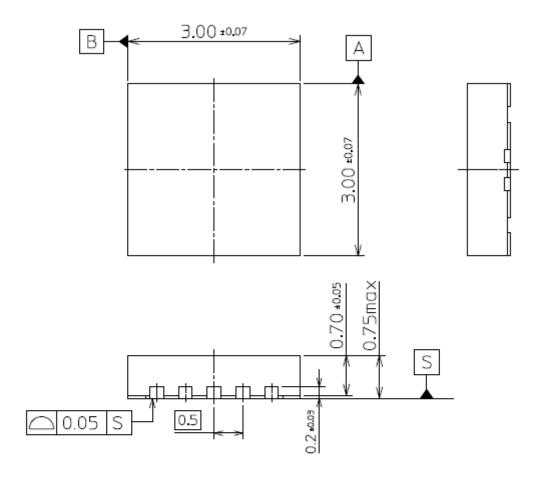


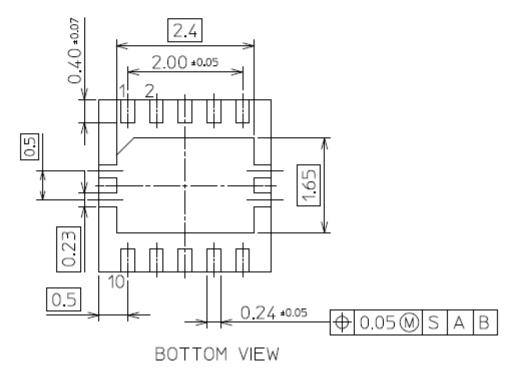
Time t (200 µs/div)



Package Dimensions

WSON10B Unit: mm



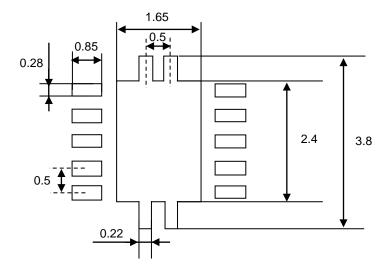


Weight: 19.3 mg (typ.)



Land pattern dimensions for reference only

Unit: mm





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